

Notice of References Cited	Application/Control No. 10/632,948		Applicant(s)/Patent Under Reexamination TOUR ET AL.	
	Examiner Matthew W. Such		Art Unit 2891	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,128,214	10-2000	Kuekes et al.	365/151
*	B	US-6,117,617	09-2000	Kanayama et al.	430/296
*	C	US-5,717,076	02-1998	Yamamoto et al.	534/558
*	D	US-5,547,748	08-1996	Ruoff et al.	428/323
*	E	US-6,448,412	09-2002	Murphy et al.	548/417
*	F	US-6,430,511	08-2002	Tour et al.	702/19
*	G	US-6,348,700	02-2002	Ellenbogen et al.	257/40
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	Chen, J. et al. SCIENCE. Vol. 286 (19 November 1999): Pages 1550-1552.			
	V	Rueckes, T. et al. SCIENCE. Vol. 289 (7 July 2000): Pages 94-97.			
	W	Wong, S. S., et al. NATURE. Vol. 394 (2 July 1998): Pages 52-55.			
	X				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.